0510-1148

IN THE U.S. PATENT AND TRADEMARK OFFICE 10/591401

In re application of

Gilbert LEGEAY et al.

Conf.

Application No. NEW NATIONAL PHASE

Group

Filed September 1, 2006

Examiner

A METHOD FOR REDUCING THE CONTAMINATION PROPERTIES OF A SURFACE BY MICRO-ORGANISMS

INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

September 1, 2006

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

- Copies of the U.S. patents or publications are not submitted since the USPTO has waived their submission for applications filed after June 30, 2003.
- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

III. CONCISE E (check at	XPLANATION OF THE RELEVANAP5 Rec'd PCT/PTO 01 SEP 2006
a. 🗌	DOCUMENTS IN THE ENGLISH LANGUAGE 10/591401
	The attached non U.S. patents, non U.S. patent application publications, foreign publications, or other information in the English language do not require a statement of relevancy.
b. 🗆	DOCUMENTS NOT IN THE ENGLISH LANGUAGE
	A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows:
c. 🛛	FOREIGN SEARCH REPORT OR ACTION
	An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement for a concise explanation. See MPEP 609(A)(3).
d. 🔲	OTHER
	The following additional information is provided for the Examiner's consideration.
FEES	
This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required.	
If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned.	
	Respectfully submitted,
	YOUNG & THOMPSON
Benoît Castel	
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BC/ldw	
Enclosures:	Form PTO-1449(s)
	Documents Foreign Council Bonort

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(Use several sheets if necessary)

Attorney Docket No.: **0510-1148**

Application 50.91401
NEW NATIONAL PHASE

Applicant: AP5 Rec'd PCT/PTO 01 SEP 2006

Filing Date:

Group Art Unit:

September 1, 2006 **U.S. PATENT DOCUMENTS** Class Subclass Filing date **Document Number** Date Name Examiner (if appropriate) Initial 4,990,547 2/5/1991 Stovicek Pavel **FOREIGN PATENT DOCUMENTS** Class Subclass Translation Country Examiner **Document Number** Date Initial Yes No 9/23/1977 FRANCE 2 342 074 9/17/1986 **EUROPE** 0 194 770 **EUROPE** 0 290 676 11/17/1988 UNITED KINGDOM 8/20/1997 2 310 140 OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) DATE CONSIDERED **EXAMINER:** EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if

not in conformance and not considered. Include copy of this form with next communication to the applicant.

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